

Search Notes

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Examiner

KEVIN L. LEE

Applicant(s)/Patent under
Reexamination

WEH ET AL.

Art Unit

3753

SEARCHED

Class	Subclass	Date	Examiner
137	614.11	5/28/2007	KL
UPDATED	SEARCH	5/28/2007	KL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
EAST	US- PGPUB	5/28/2007	KL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search (US-PGPUB)	5/28/2007	KL